

APPENDIX 3: Photographs of test setup

Conducted Emission



Photo 1



Photo 2

UL Japan, Inc.

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Radiated Spurious Emission (30 – 1000MHz)



Photo 1

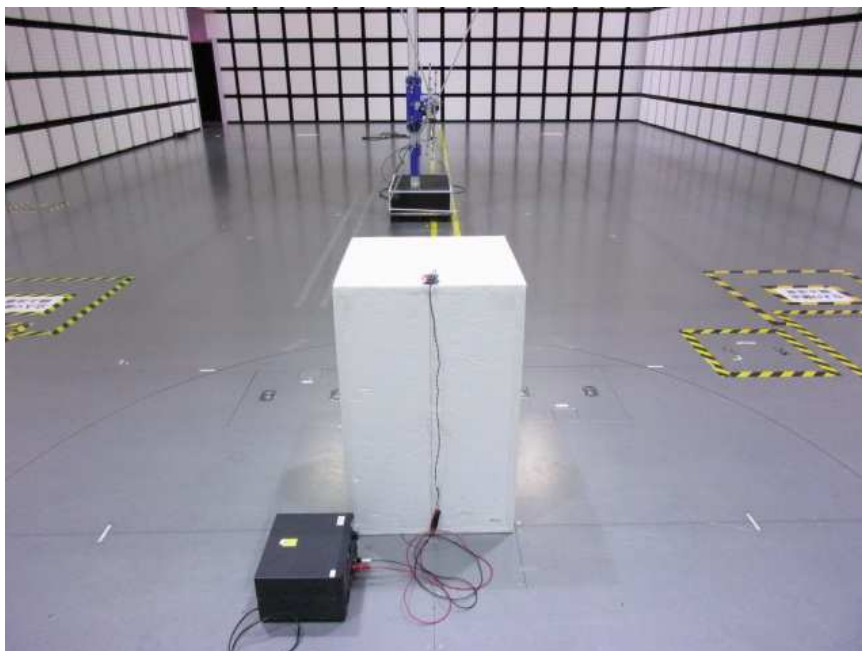


Photo 2

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Radiated Spurious Emission (1 – 26GHz)

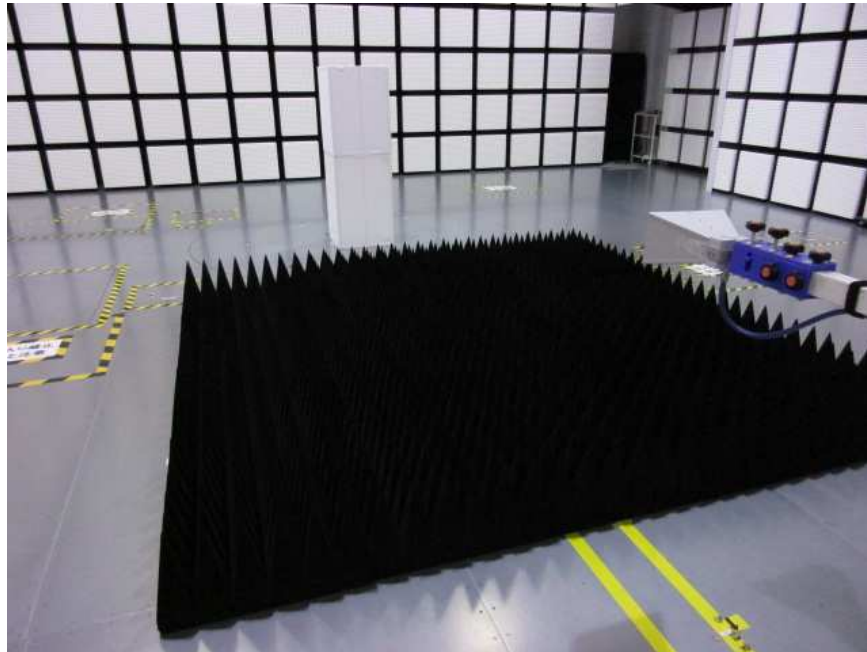


Photo 1

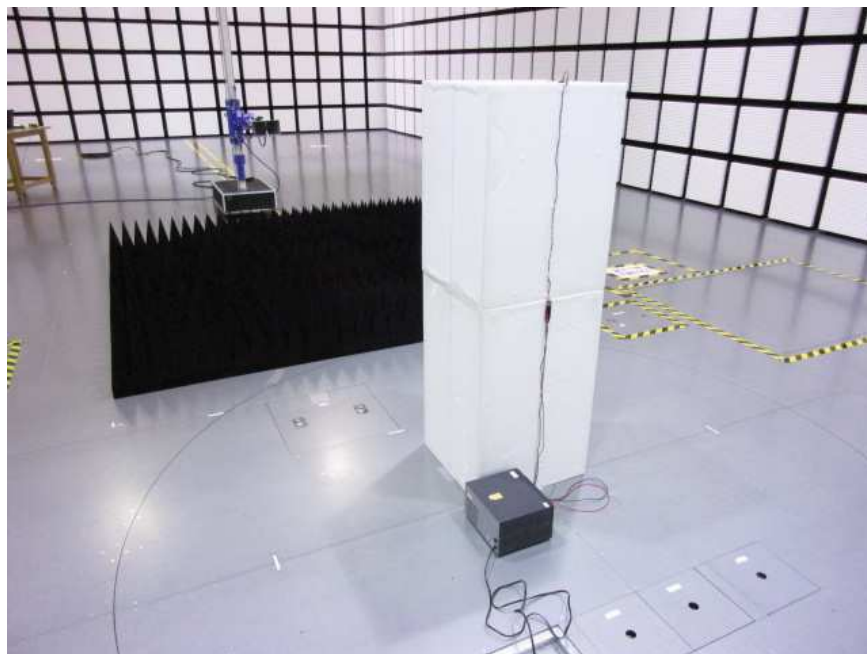


Photo 2

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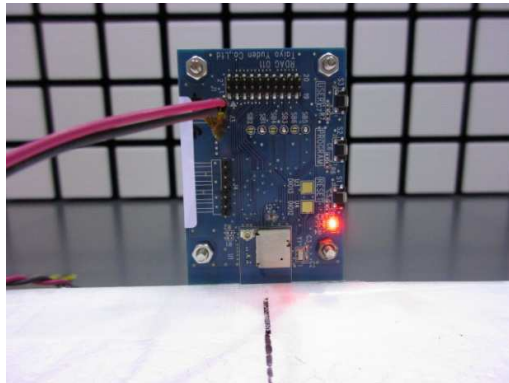
Facsimile : +81-478-82-3373

Worst Case Position (X-axis)

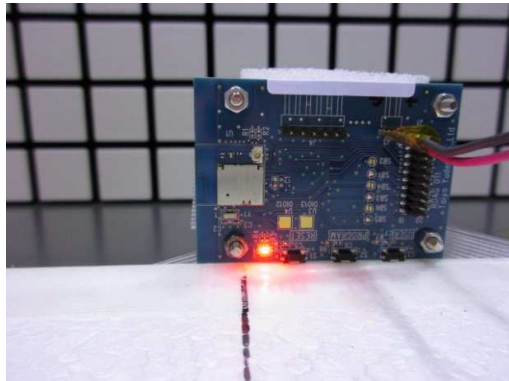
X-axis



Y-axis



Z-axis



*Use the motherboard with no metal plate, therefore this motherboard does not affect the module test condition.

End of Report

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